



<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10079723</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>KWAK ET AL.</p>
	<p>Examiner</p> <p>Mills, Donald L</p>	<p>Art Unit</p> <p>2616</p>

Class	SubClass	Date	Examiner
370	230, 230.1, 231, 235, 310.1, 315, 328, 329, 335, 342, 395.61, 441	07/06/2006	DLM
U.S. Patent and Trademark Office		Part of Paper No.: 20060706	

<b>Search Notes</b>  	Application/Control No.  10079723	Applicant(s)/Patent Under Reexamination  KWAK ET AL.
	Examiner Mills, Donald L	Art Unit 2616

Notes	Date	Examiner
EAST (US PGPUBS, USPATs, EPO, JPO, IBM, DERWENT)	07/06/2006	DLM
IEEE - <a href="http://ieee.ieeeexplore.org">ieee.ieeeexplore.org</a> - CDMA	07/06/2006	DLM
Internet - <a href="http://google.com">google.com</a> - CDMA	07/06/2006	DLM
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